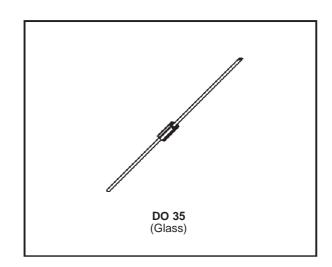


# SMALL SIGNAL SCHOTTKY DIODES



## **DESCRIPTION**

General purpose, metal to silicon diodes featuring very low turn-on voltage fast switching.

These devices have integrated protection against excessive voltage such as electrostatic discharges.

# **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit	
$V_{RRM}$	Repetitive Peak Reverse Voltage	30	V	
I <sub>F</sub>	Forward Continuous Current $T_a = 25 ^{\circ}\text{C}$		200	mA
I <sub>FRM</sub>	$\begin{array}{c} \text{Repetitive Peak Fordware Current} & t_p \leq 1s \\ \delta \leq 0.5 & \end{array}$		500	mA
I <sub>FSM</sub>	Surge non Repetitive Forward Current* t	4	Α	
P <sub>tot</sub>	Power Dissipation*	200	mW	
T <sub>stg</sub> T <sub>j</sub>	Storage and Junction Temperature Range	- 65 to +150 - 65 to +125	ပို ပို	
TL	Maximum Temperature for Soldering during 10s at	230	°C	

## THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
$R_{th(j-a)}$	Junction-ambient*	300	°C/W

<sup>\*</sup> On infinite heatsink with 4mm lead length

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# **ELECTRICAL CHARACTERISTICS**

## STATIC CHARACTERISTICS

Symbol	Test Conditions			Min.	Тур.	Max.	Unit
$V_{BR}$	Tj = 25°C	$I_R = 100 \mu A$		30			V
V <sub>F</sub> *	T <sub>j</sub> = 25°C	$I_F = 200 \text{mA}$	All Types			1	V
	T <sub>j</sub> = 25°C	$I_F = 10 \text{mA}$	BAT 42			0.4	
	T <sub>j</sub> = 25°C	$I_F = 50 \text{mA}$	]			0.65	
	T <sub>j</sub> = 25°C	$I_F = 2mA$	BAT 43	0.26		0.33	
	T <sub>j</sub> = 25°C	$I_F = 15mA$				0.45	
I <sub>R</sub> *	T <sub>j</sub> = 25°C		V <sub>R</sub> = 25V			0.5	μΑ
	T <sub>j</sub> = 100°C					100	

## **DYNAMIC CHARACTERISTICS**

Symbol	Test Conditions	Min.	Тур.	Max.	Unit
С	$T_j = 25^{\circ}C$ $V_R = 1V$ $f = 1MHz$		7		pF
trr	$Tj = 25^{\circ}C  I_F = 10 \text{mA}  I_R = 10 \text{mA}  I_{rr} = 1 \text{mA}  R_L = 100 \Omega$			5	ns
h	$T_j = 25^{\circ}C$ $R_L = 15K\Omega$ $C_L = 300pF$ $f = 45MHz$ $V_i = 2V$	80			%

<sup>\*</sup> Pulse test:  $t_p \le 300 \mu s$   $\delta < 2\%$ .

Figure 1. Forward current versus forward voltage at different temperatures (typical values).

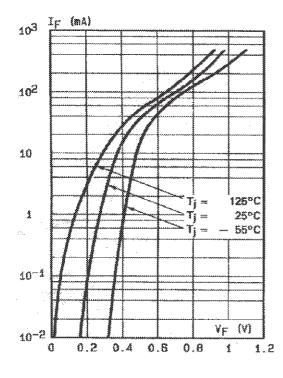
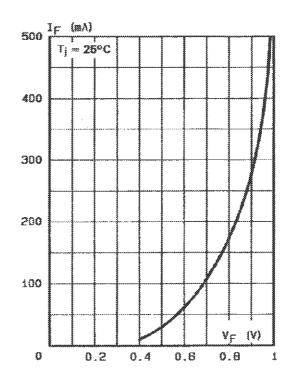


Figure 2. Forward current versus forward voltage (typical values).



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Figure 3. Reverse current versus junction temperature (typical values).

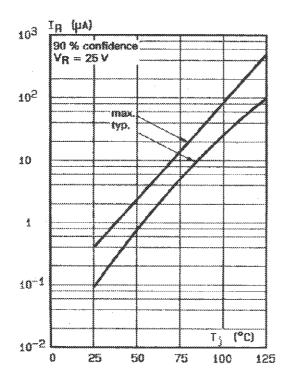


Figure 4. Reverse current versus continuous reverse voltage.

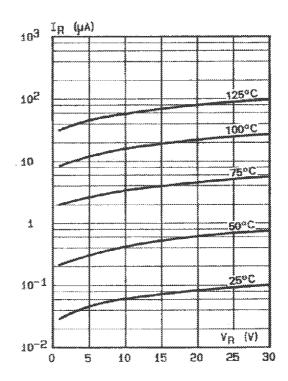
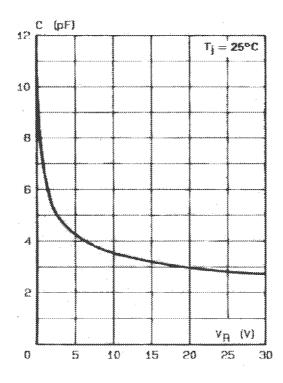
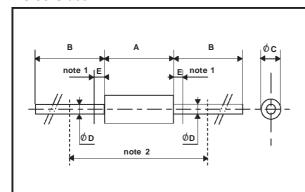


Figure 5. Capacitance C versus reverse applied voltage  $V_{\mbox{\scriptsize R}}$  (typical values).



#### PACKAGE MECHANICAL DATA

#### DO 35 Glass



	DIMENSIONS				
REF.	Millimeters		Millimeters Inches		
	Min.	Max.	Min.	Max.	
А	3.05	4.50	0.120	0.177	
В	1.53	2.00	0.060	0.079	
С	12.7		0.500		
D	0.458	0.558	0.018	0.022	

Cooling method: by convection and conduction Marking: clear, ring at cathode end. Weight: 0.15g

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